

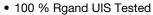
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N-Channel 120 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^{a, d}	Q _g (Typ.)			
120	0.006 at V _{GS} = 10 V	100	88nC			

FEATURES

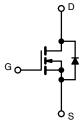




COMPLIANT

APPLICATIONS

- Synchronous rectification
- Primary side switch
- DC/DC converters
- OR-ing
- Power supplies
- Motor drive control
- Battery and load switch



N-Channel MOSFET

Top View	Bottom View
PIN1	(A)

DFN5X6

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	120	V	
Gate-source voltage		V_{GS}	± 20		
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		100 ^a		
	$T_C = 70 ^{\circ}C$		81.7		
	T _A = 25 °C	I _D	30.2 b, c		
	T _A = 70 °C	1	13.9 b, c	^	
Pulsed drain current (t = 100 μs)		I _{DM}	400	Α	
	T _C = 25 °C		100 a		
Continuous source-drain diode current	T _A = 25 °C	l _S	6.1 b, c	[
Single pulse avalanche current L = 0.1 mH		I _{AS}	73		
Single pulse avalanche energy	L = 0.1 IIII	E _{AS}	115	mJ	
Maximum power dissipation	T _C = 25 °C		169		
	T _C = 70 °C		105	10/	
	T _A = 25 °C	P _D	5.85 b, c	W	
	T _A = 70 °C	1	3.2 b, c	7	
Operating junction and storage temperature range		T _J , T _{stq}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^c		1	260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R_{thJA}	14	25			
Maximum junction-to-case (drain)	Steady state	R_{thJC}	0.7	1	°C/W		
Maximum junction-to-case (source)	Steady state	R _{thJC}	1.0	1.5			

a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.

d. Calculated based on maximum junction temperature.

Rev. 1.1



PARAMETER	SYMBOL	MBOL TEST CONDITIONS		TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	120	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	-	56	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-6	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5	-	2.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	-	-	1	μА	
Zero gate voltage drain current		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 70 ^{\circ}\text{C}$	-	-	10		
On-state drain current ^a	$I_{D(on)}$	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100	-	-	Α	
Drain-source on-state resistance a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.006	0.0075	Ω	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	68	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	4915	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	620	-		
Reverse transfer capacitance	C _{rss}		-	32	-		
Total gate charge	Qg		-	68	-	nC	
Gate-source charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	-	32	-		
Gate-drain charge	Q _{gd}		-	11	-		
Output charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	-	33	-		
Gate resistance	R _g	f = 1 MHz	0.4	1.1	2	Ω	
Turn-on delay time	t _{d(on)}		-	13	-		
Rise time	t _r	$V_{DD} = 50 \text{ V}, \text{ R}_L = 2.5 \Omega, \text{ I}_D \cong 20 \text{ A},$	-	8	-	ns	
Turn-off delay time	t _{d(off)}	V_{GEN} = 10 V, R_g = 1 Ω	-	45	-	- 115	
Fall time	t _f		-	12	-		
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	Is	T _C = 25 °C -		-	100	- A	
Pulse diode forward current (t _p = 100 μs)	I _{SM}			-	400		
Body diode voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.7	1.2	V	
Body diode reverse recovery time	t _{rr}		-	30	38	ns	
Body diode reverse recovery charge Q _{rr}		L = 20 A di/dt = 100 A/::2 T = 05.90	-	78	136	nC	
Reverse recovery fall time	ta	$I_F = 20 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		25	-		
Reverse recovery rise time	t _b		-	20	-	ns	

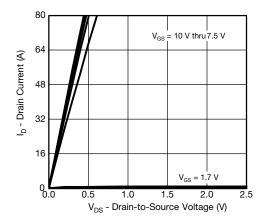
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

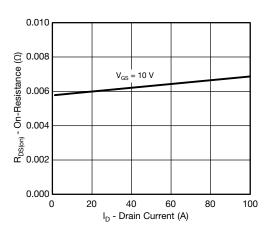
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



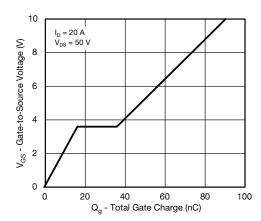
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



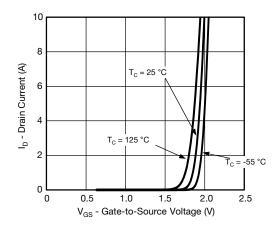
Output Characteristics



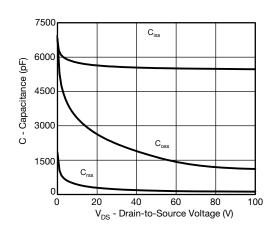
On-Resistance vs. Drain Current and Gate Voltage



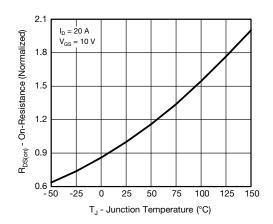
Gate Charge



Transfer Characteristics



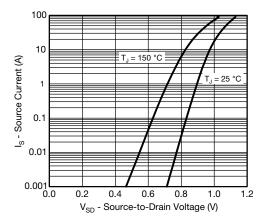
Capacitance



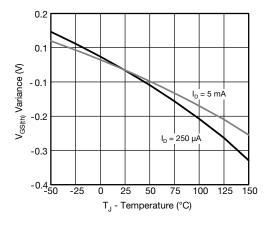
On-Resistance vs. Junction Temperature



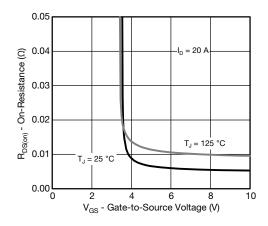
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



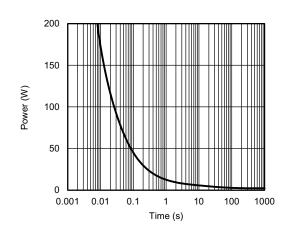
Source-Drain Diode Forward Voltage



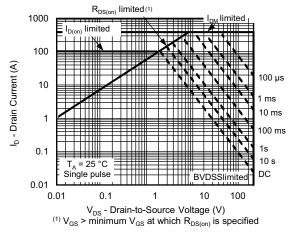
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



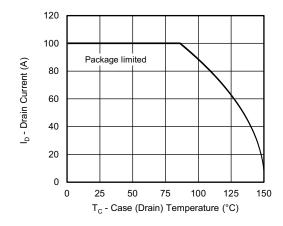
Single Pulse Power, Junction-to-Ambient

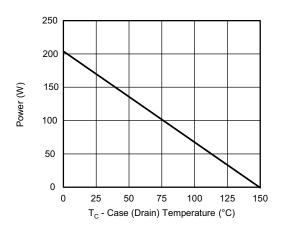


Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Current Derating a

Power, Junction-to-Case

Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





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